# **Power MOSFET**

# 30 V, 8.2 A, Single N-Channel, **ChipFET™ Package**

#### **Features**

- Trench Technology
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Leadless ChipFET Package has 40% Smaller Footprint than TSOP-6
- Excellent Thermal Capabilities
- This is a Pb-Free Device

## **Applications**

- Load Switching
- DC-DC Converters
- Low Side Switching

## MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Param	Symbol	Value	Unit			
Drain-to-Source Voltag	$V_{DSS}$	30	V			
Gate-to-Source Voltage	Э		$V_{GS}$	±20	V	
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	6.6	Α	
Current R <sub>θJA</sub> (Note 1)		T <sub>A</sub> = 85°C		4.8		
Power Dissipation R <sub>θJA</sub> (Note 1)	Steady	T <sub>A</sub> = 25°C	P <sub>D</sub>	1.5	W	
Continuous Drain	State	T <sub>A</sub> = 25°C	I <sub>D</sub>	4.9	Α	
Current R <sub>θJA</sub> (Note 2)		T <sub>A</sub> = 85°C		3.6		
Power Dissipation $R_{\theta JA}$ (Note 2)	T <sub>A</sub> = 25°C		P <sub>D</sub>	0.8	W	
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	8.2	Α	
Current $R_{\theta JA}$ , $t \le 5 s$ (Note 1)	Steady State	T <sub>A</sub> = 85°C		5.9		
Power Dissipation R <sub>θJA</sub> (Note 1)	State	T <sub>A</sub> = 25°C	P <sub>D</sub>	2.2	W	
Pulsed Drain Current	I <sub>DM</sub>	32	Α			
Operating Junction and	T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C			
Source Current (Body D	IS	2.6	Α			
Single Pulse Drain-to-S Energy $T_J = 25^{\circ}C$ , $V_{DD}$ $I_L = 20 A_{pk}$ , $L = 0.1 mH$ ,	EAS	20	mJ			
Lead Temperature for S (1/8" from case for 1	TL	260	°C			

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface Mounted on FR4 Board using 1 in sq. pad, 1 oz Cu.

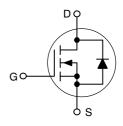
- 2. Surface Mounted on FR4 Board using the minimum recommended pad size.



## ON Semiconductor®

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V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> Max	I <sub>D</sub> Max	
30 V	22 mΩ @ 10 V	8.2 A	
	27 mΩ @ 4.5 V	0.27	



**N-Channel MOSFET** 

## **MARKING DIAGRAM** AND PIN ASSIGNMENT



ChipFET **CASE 1206A** STYLE 1



466 = Specific Device Code = Month Code = Pb-Free Package

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>		
NTHS4166NT1G	ChipFET (Pb-Free)	3000/Tape & Reel		

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

## THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 3)	$R_{ heta JA}$	86	°C/W
Junction-to-Ambient – t ≤ 5 s (Note 3)	$R_{ heta JA}$	57	
Junction-to-Ambient – t ≤ 5 s (Note 4)	$R_{ heta JA}$	155	
Junction-to-Foot (Drain) Steady State (Note 3)	$R_{ hetaJF}$	20	

## **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Condition	ıs	Min	Тур	Max	Units
OFF CHARACTERISTICS					-	-	-
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				18.3		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 30 V	T <sub>J</sub> = 25°C			1.0	μΑ
			T <sub>J</sub> = 125°C			10	1
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ±	±20 V			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}$ , $I_D = 25$	50 μΑ	1.1		2.3	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				5.5		mV/°C
Drain-to-Source On-Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 4	1.9 A		18	22	mΩ
		$V_{GS} = 4.5 \text{ V}, I_D = 3$	3.7 A		23	27	1
Forward Transconductance	9FS	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 4.9 A			9.0		S
CHARGES AND CAPACITANCES					•	-	•
Input Capacitance	C <sub>ISS</sub>				900		pF
Output Capacitance	C <sub>OSS</sub>	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz, V}_{DS} = 15 \text{ V}$			210		1 '
Reverse Transfer Capacitance	C <sub>RSS</sub>				140		1
Total Gate Charge	Q <sub>G(TOT)</sub>				9.2		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	\/			0.85		1
Gate-to-Source Charge	$Q_{GS}$	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}, I_D = 4.9 \text{ A}$			2.86		1
Gate-to-Drain Charge	$Q_{GD}$				3.84		1
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 15 V,	I <sub>D</sub> = 4.9 A		18		nC
Gate Resistance	$R_{G}$				1.6		
SWITCHING CHARACTERISTICS (Note	e 6)				-	•	-
Turn-On Delay Time	t <sub>d(on)</sub>				12		ns
Rise Time	t <sub>r</sub>	$V_{GS}$ = 4.5 V, $V_{DS}$ = 15 V, $I_D$ = 4.9 A, $R_G$ = 3.0 $\Omega$			13		
Turn-Off Delay Time	t <sub>d(off)</sub>				16		
Fall Time	t <sub>f</sub>				5.0		
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 15 V, $I_{D}$ = 4.9 A, $R_{G}$ = 3.0 $\Omega$			8.0		ns
Rise Time	t <sub>r</sub>				11		
Turn-Off Delay Time	t <sub>d(off)</sub>				20		
Fall Time	t <sub>f</sub>				4.0		1

Surface Mounted on FR4 Board using 1 in sq. pad, 1 oz Cu.
 Surface Mounted on FR4 Board using the minimum recommended pad size.

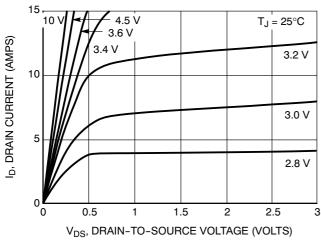
<sup>5.</sup> Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter	Symbol	Test Conditio	Min	Тур	Max	Units			
DRAIN-SOURCE DIODE CHARACTERISTICS									
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 \text{ V}, I_S = 5.2 \text{ A}$	T <sub>J</sub> = 25°C		0.83	1.0	V		
			T <sub>J</sub> = 125°C		0.7				
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 5.2 A, dI <sub>S</sub> /dt = 100 A/μs			16		ns		
Charge Time	ta				7.5				
Discharge Time	t <sub>b</sub>				8.5				
Reverse Recovery Charge	Q <sub>RR</sub>	1		6.0		nC			

<sup>5.</sup> Pulse Test: Pulse Width  $\leq$  300  $\mu$ s, Duty Cycle  $\leq$  2%. 6. Switching characteristics are independent of operating junction temperatures.

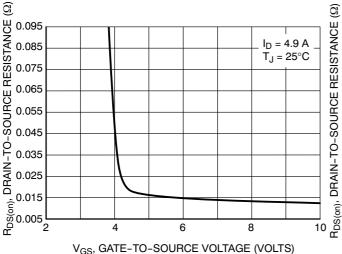
## **TYPICAL PERFORMANCE CURVES**



 $V_{DS} \ge 10 \text{ V}$   $V_{DS} \ge 10 \text{ V}$ 

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



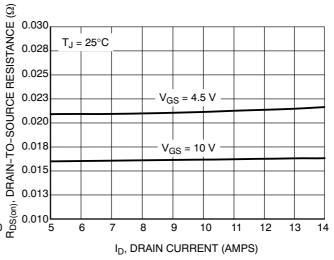
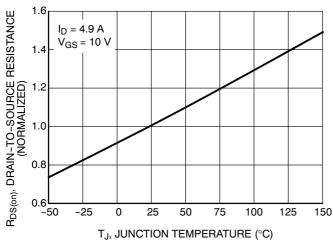


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



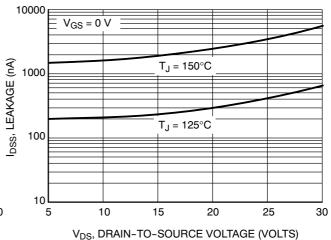


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Drain Voltage

## TYPICAL PERFORMANCE CURVES

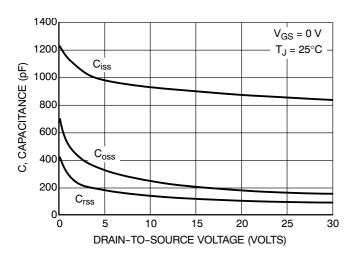


Figure 7. Capacitance Variation

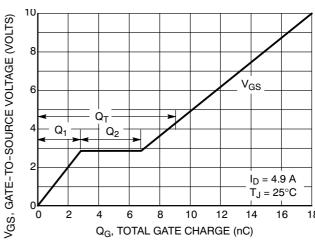


Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge

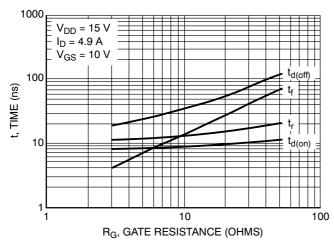


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

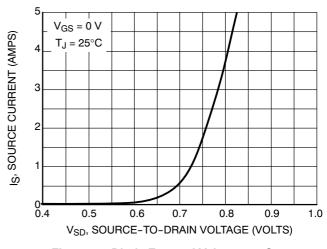


Figure 10. Diode Forward Voltage vs. Current

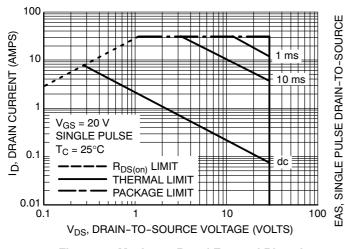


Figure 11. Maximum Rated Forward Biased Safe Operating Area

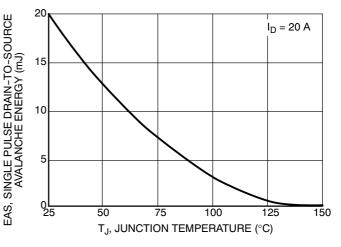
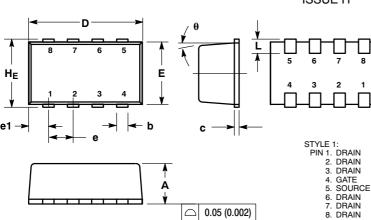


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

#### PACKAGE DIMENSIONS

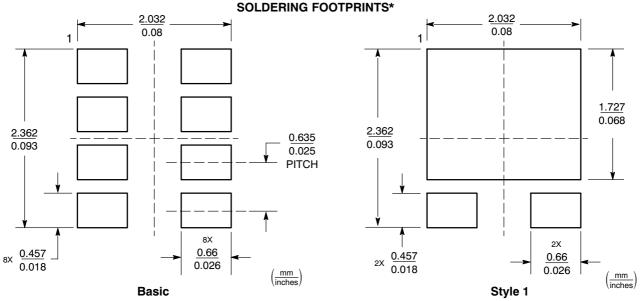
## **ChipFET™** CASE 1206A-03 **ISSUE H**



#### NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  CONTROLLING DIMENSION: MILLIMETER.
  MOLD GATE BURRS SHALL NOT EXCEED 0.13 MM PER SIDE.
  LEADFRAME TO MOLDED BODY OFFSET IN HORIZONTAL
- AND VERTICAL SHALL NOT EXCEED 0.08 MM
- DIMENSIONS A AND B EXCLUSIVE OF MOLD GATE BURBS
- NO MOLD FLASH ALLOWED ON THE TOP AND BOTTOM LEAD SURFACE

	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	1.00	1.05	1.10	0.039	0.041	0.043	
b	0.25	0.30	0.35	0.010	0.012	0.014	
С	0.10	0.15	0.20	0.004	0.006	0.008	
D	2.95	3.05	3.10	0.116	0.120	0.122	
E	1.55	1.65	1.70	0.061	0.065	0.067	
е	0.65 BSC			0.025 BSC			
e1	0.55 BSC				0.022 BSC		
L	0.28	0.35	0.42	0.011	0.014	0.017	
HE	1.80	1.90	2.00	0.071	0.075	0.079	
θ	5° NOM				5° NOM		



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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